

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	72	382/211.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 14:59
L2	58	382/211.ccls. and pattern	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:02
L3	20	382/211.ccls. and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:04
L4	739	382/312.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:04
L5	83	382/312.ccls. and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:04
L6	12	382/312.ccls. and (pattern with (memory or stor\$4)) and shutter	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:05
L7	2	382/313.ccls. and (pattern with (memory or stor\$4)) and shutter	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:07
L8	39	348/740.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:07

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L9	39	348/740.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:08
L10	297	359/259.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:09
L11	14	359/259.ccls. and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:12
L12	393	396/452.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:13
L13	2	396/452.ccls. and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:13
L14	90	396/457.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:14
L15	2	396/457.ccls. and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 15:14
S1	1	("5822117").PN.	USPAT; EPO	OR	OFF	2006/04/07 09:47
S2	103760	pattern with (exposure or shutter or lens)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:48

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S3	13691	pattern with (exposure or shutter or lens) and camera	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:48
S4	5328	pattern with (exposure or shutter or lens)with (picture or image) and camera	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:49
S5	1594	pattern with (exposure or shutter or lens)with (picture or image) and camera and shutter	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:49
S6	21	pattern with (exposure or shutter or lens)with (picture or image) and camera and (shutter with address\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:56
S7	18	pattern with (exposure or shutter)with (picture or image) and camera and (shutter with address\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:56
S8	32	pattern with (exposure or shutter)with (picture or image) and (shutter with address\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 09:59
S9	356	pattern with (exposure or shutter or modulator)with (picture or image) and ((shutter or modulator) with address\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 10:00
S10	198	pattern with (exposure or shutter or modulator)with (picture or image) and ((shutter or modulator) with address\$4)and camera	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 10:01

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S11	87	pattern with (exposure or shutter or modulator)with (picture or image) and ((shutter or modulator) with address\$4)and camera and (pattern with memory)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 10:08
S12	161	pattern with (exposure or shutter or modulator)with (picture or image) and ((shutter or modulator) with address\$4)and camera and (pattern with memory or stor\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 10:09
S13	101	pattern with (exposure or shutter or modulator)with (picture or image) and ((shutter or modulator) with address\$4)and camera and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 10:45
S14	134	pattern with (exposure or shutter or modulator) and ((shutter or modulator) with address\$4)and camera and (pattern with (memory or stor\$4))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/07 10:46


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IEEE CNF IEEE Conference Proceeding

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- 2. **Real-time displacement measurement using a pattern correlation system an ultra-high-speed shutter camera and parallel aligned nematic liquid crystal modulators (PAL-SLMs)**
Toyoda, H.; Kobayashi, Y.; Mukohzaka, N.; Yoshida, N.; Hara, T.; Ohno, T.; [Instrumentation and Measurement Technology Conference, 1994. IMTC/94. Conference Proceedings. 10th Anniversary. Advanced Technologies in I & M., 1994 IEEE](#) 10-12 May 1994 Page(s):1345 - 1348 vol.3
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